

<b>Notice of References Cited</b>	Application/Control No. 10/091,573	Applicant(s)/Patent Under Reexamination KRAENZEL ET AL.	
	Examiner Tan Dean D. Nguyen	Art Unit 3689	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,960,173	09-1999	Tang et al.	709/201
*	B	US-2004/0014457	01-2004	Stevens, Lawrence A.	455/414.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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